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Application/Control No.	Applicant(s)/Patent Reexamination	under
10/797,037	NOZAWA ET AL.	
Examiner	Art Unit	·
Alexa D. Neckel	1764	

			
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Class	Subclass	Date	Examiner
422	139 141 145 146 147	10/13/2005	ADN
423	335 337 342	10/13/2005	ADN
427	213 215	10/13/2005	ADN
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventorship Search	10/13/2005	ADN		
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EAST Search (see search history printout)	10/13/2005	ADN		
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